

Appendix D:DASY System Calibration Certificate

1、DAE4-SN:387:Due Date(2026-10-12)

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates			S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage S Servizio svizzero di taratura S Swiss Calibration Service Accreditation No.: SCS 0108
Client: Anbotek Shenzhen	Certificate No: DAE4-387_Oct25		

CALIBRATION CERTIFICATE

Object	DAE4 - SD 000 D04 BM - SN: 387
Calibration procedure(s)	QA CAL-06.v30 Calibration procedure for the data acquisition electronics (DAE)
Calibration date:	October 13, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	15-Aug-25 (No:43873)	Aug-26

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	23-Jan-25 (in house check)	In house check: Jan-26
Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-25 (in house check)	In house check: Jan-26

Calibrated by:	Name Adrian Gehring	Function Laboratory Technician	Signature 
Approved by:	Sven Kühn	Technical Manager	

Issued: October 13, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: DAE4-387_Oct25

Page 1 of 5

Shenzhen Anbotek Compliance Laboratory Limited

Any unauthorized modification, forgery, or falsification of this document constitutes a violation of law and is subject to legal penalties. If you have any questions, you may scan the QR code to download the report for verification or contact us via email.

Hotline: 400-003-0500 web: www.anbotek.com E-mail: service@anbotek.com

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information; DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.999 $\pm$ 0.02% (k=2)	404.667 $\pm$ 0.02% (k=2)	404.848 $\pm$ 0.02% (k=2)
Low Range	3.98758 $\pm$ 1.50% (k=2)	3.98918 $\pm$ 1.50% (k=2)	3.94762 $\pm$ 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	53.0 ° $\pm$ 1 °
---	------------------

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15998	15780
Channel Y	16013	15795
Channel Z	15883	15916

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	0.44	-0.73	1.58	0.43
Channel Y	0.59	-1.06	2.22	0.42
Channel Z	-0.93	-1.80	-0.11	0.34

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

2、EX3DV4-SN:3959:Due Date(2026-10-08)

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates			S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage S Servizio svizzero di taratura S Swiss Calibration Service Accreditation No.: SCS 0108
--	---	---	---

Client Anbotek Shenzhen	Certificate No. EX-3959_Oct25
---	---

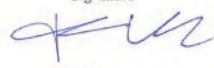
CALIBRATION CERTIFICATE

Object	EX3DV4 - SN:3959
Calibration procedure(s)	QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6, QA CAL-25.v8, QA CAL-48.v2 Calibration procedure for dosimetric E-field probes
Calibration date	October 09, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.
All calibrations have been conducted in the closed laboratory facility: environment temperature (22±3)°C and humidity < 70%.
Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched. Cal.
Power Sensor R&S NRP-33T	SN: 100967	30-Apr-25 (No. 1020-300791789)	Apr-26
N-type mismatch combination	SN: L1119	26-Mar-25 (No. 217-04292)	Mar-26
OCF DAK-12	SN: 1016	16-Sept-25 (No. OCP-DAK12-1016_Sep25)	Sep-26
OCF DAK-3.5	SN: 1249	16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)	Sep-26
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched. Check
ACAP 2020 Setup 1	SN: L1404	01-Oct-25 (No. IHCK_ACAP2020-1_Oct25)	Oct-26
OCF DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26
OCF DAK-3.5	SN: 1336	09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)	Dec-25

	Name	Function	Signature
Calibrated by	Jeton Kastrati	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	

Issued: October 09, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: EX-3959_Oct25	Page 1 of 9
-------------------------------	-------------

Shenzhen Anbotek Compliance Laboratory Limited

Any unauthorized modification, forgery, or falsification of this document constitutes a violation of law and is subject to legal penalties. If you have any questions, you may scan the QR code to download the report for verification or contact us via email.

Hotline: 400-003-0500 web: www.anbotek.com E-mail: service@anbotek.com

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client **Anbotek**
Shenzhen

Certificate No. **EX-3959_Oct25**

CALIBRATION CERTIFICATE

Object **EX3DV4 - SN:3959**

Calibration procedure(s) **QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,
QA CAL-25.v8, QA CAL-48.v2
Calibration procedure for dosimetric E-field probes**

Calibration date **October 09, 2025**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.
All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3) °C and humidity < 70%.
Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched. Cal.
Power Sensor R&S NRP-33T	SN: 100967	30-Apr-25 (No. 1020-300791789)	Apr-26
N-type mismatch combination	SN: L1119	26-Mar-25 (No. 217-04292)	Mar-26
OCP DAK-12	SN: 1016	16-Sept-25 (No. OCP-DAK12-1016_Sep25)	Sep-26
OCP DAK-3.5	SN: 1249	16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)	Sep-26
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched. Check
ACAP 2020 Setup 1	SN: L1404	01-Oct-25 (No. IHCK ACAP2020-1_Oct25)	Oct-26
OCP DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26
OCP DAK-3.5	SN: 1336	09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)	Dec-25

	Name	Function	Signature
Calibrated by	Jeton Kastrati	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	

Issued: October 09, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Glossary

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\theta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\theta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; D_{x,y,z}; VR_{x,y,z}; A, B, C, D** are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Glossary

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\theta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\theta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; D_{x,y,z}; VR_{x,y,z}; A, B, C, D** are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

EX3DV4 - SN:3959

October 09, 2025

Parameters of Probe: EX3DV4 - SN:3959

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k = 2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.49	0.42	0.58	±10.1%
DCP (mV) ^B	101.0	103.3	101.4	±4.7%

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB $\sqrt{\mu\text{V}}$	C	D dB	VR mV	Max dev.	Max Unc ^E k = 2
0	CW	X	0.00	0.00	1.00	0.00	126.0	±1.2%	±4.7%
		Y	0.00	0.00	1.00		148.8		
		Z	0.00	0.00	1.00		138.6		

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 5).

^B Linearization parameter uncertainty for maximum specified field strength.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

EX3DV4 - SN:3959

October 09, 2025

Parameters of Probe: EX3DV4 - SN:3959

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k = 2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.49	0.42	0.58	±10.1%
DCP (mV) ^B	101.0	103.3	101.4	±4.7%

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB $\sqrt{\mu\text{V}}$	C	D dB	VR mV	Max dev.	Max Unc ^E k = 2
0	CW	X	0.00	0.00	1.00	0.00	126.0	±1.2%	±4.7%
		Y	0.00	0.00	1.00		148.8		
		Z	0.00	0.00	1.00		138.6		

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 5).

^B Linearization parameter uncertainty for maximum specified field strength.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

EX3DV4 - SN:3959

October 09, 2025

Parameters of Probe: EX3DV4 - SN:3959

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle	-35.6°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	12 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3–4 mm for an *Area Scan* job.

EX3DV4 - SN:3959

October 09, 2025

Parameters of Probe: EX3DV4 - SN:3959

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle	-35.6°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	12 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3–4 mm for an *Area Scan* job.

EX3DV4 - SN:3959

October 09, 2025

Parameters of Probe: EX3DV4 - SN:3959

Calibration Parameter Determined in HSL

f (MHz) ^C	Relative Permittivity ^F	Conductivity ^F (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc ^H (k = 2)
750	41.9	0.89	9.82	10.29	9.84	0.35	1.27	±11.0%
835	41.5	0.90	9.61	10.08	9.63	0.35	1.27	±11.0%
900	41.5	0.97	9.45	9.90	9.47	0.34	1.27	±11.0%
1750	40.1	1.37	8.02	8.41	8.04	0.33	1.27	±11.0%
1900	40.0	1.40	7.78	8.16	7.80	0.33	1.27	±11.0%
2450	39.2	1.80	7.26	7.62	7.28	0.33	1.27	±11.0%
2600	39.0	1.96	7.14	7.48	7.15	0.32	1.27	±11.0%
5250	35.9	4.71	5.70	5.98	5.71	0.29	1.27	±13.1%
5600	35.5	5.07	5.29	5.54	5.30	0.27	1.27	±13.1%
5750	35.4	5.22	5.35	5.61	5.36	0.25	1.27	±13.1%

^C Frequency validity above 300 MHz of ±100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ±50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ±10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to ±110 MHz.

^F The probes are calibrated using tissue simulating liquids (TSL) that deviate for ϵ and σ by less than ±5% from the target values (typically better than ±3%) and are valid for TSL with deviations of up to ±10% if SAR correction is applied.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

^H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

EX3DV4 - SN:3959

October 09, 2025

Parameters of Probe: EX3DV4 - SN:3959

Calibration Parameter Determined in HSL

f (MHz) ^C	Relative Permittivity ^F	Conductivity ^F (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc ^H (k = 2)
750	41.9	0.89	9.82	10.29	9.84	0.35	1.27	±11.0%
835	41.5	0.90	9.61	10.08	9.63	0.35	1.27	±11.0%
900	41.5	0.97	9.45	9.90	9.47	0.34	1.27	±11.0%
1750	40.1	1.37	8.02	8.41	8.04	0.33	1.27	±11.0%
1900	40.0	1.40	7.78	8.16	7.80	0.33	1.27	±11.0%
2450	39.2	1.80	7.26	7.62	7.28	0.33	1.27	±11.0%
2600	39.0	1.96	7.14	7.48	7.15	0.32	1.27	±11.0%
5250	35.9	4.71	5.70	5.98	5.71	0.29	1.27	±13.1%
5600	35.5	5.07	5.29	5.54	5.30	0.27	1.27	±13.1%
5750	35.4	5.22	5.35	5.61	5.36	0.25	1.27	±13.1%

^C Frequency validity above 300 MHz of ±100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ±50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ±10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to ±110 MHz.

^F The probes are calibrated using tissue simulating liquids (TSL) that deviate for ϵ and σ by less than ±5% from the target values (typically better than ±3%) and are valid for TSL with deviations of up to ±10% if SAR correction is applied.

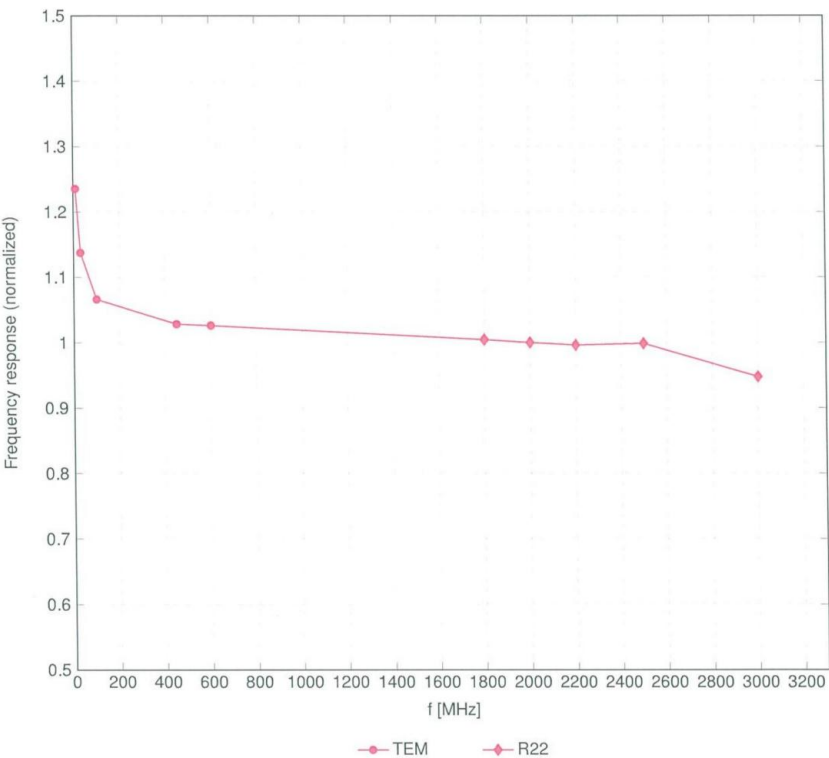
^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

^H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

EX3DV4 - SN:3959

October 09, 2025

Frequency Response of E-Field
(TEM-Cell:ifi110 EXX, Waveguide:R22)

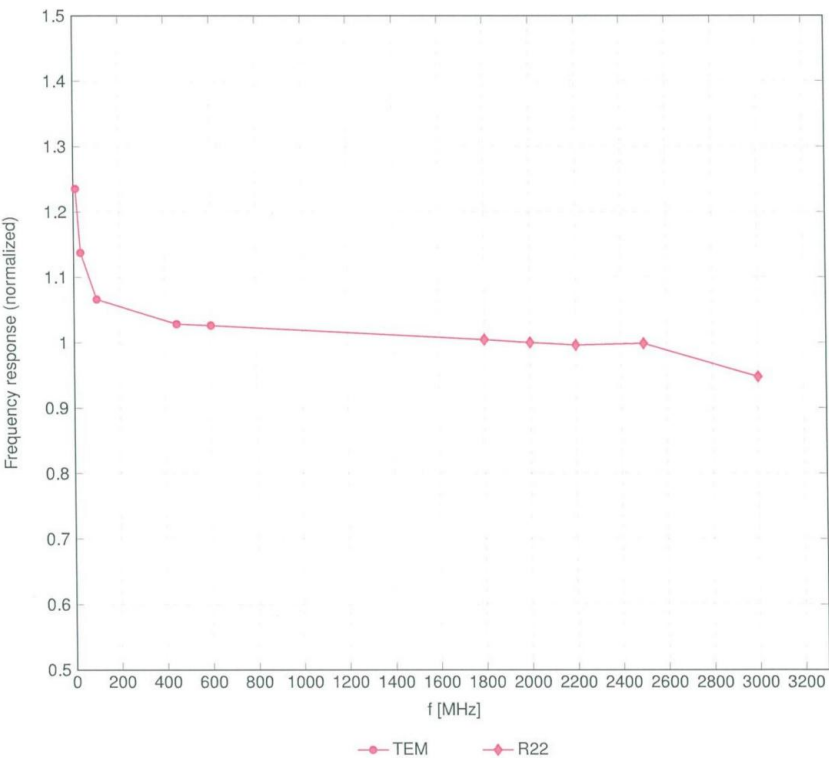


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

EX3DV4 - SN:3959

October 09, 2025

Frequency Response of E-Field
(TEM-Cell:ifi110 EXX, Waveguide:R22)

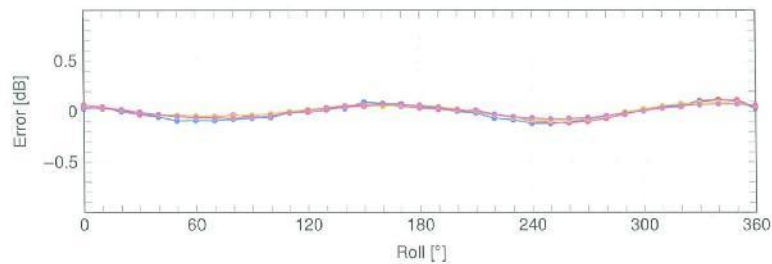
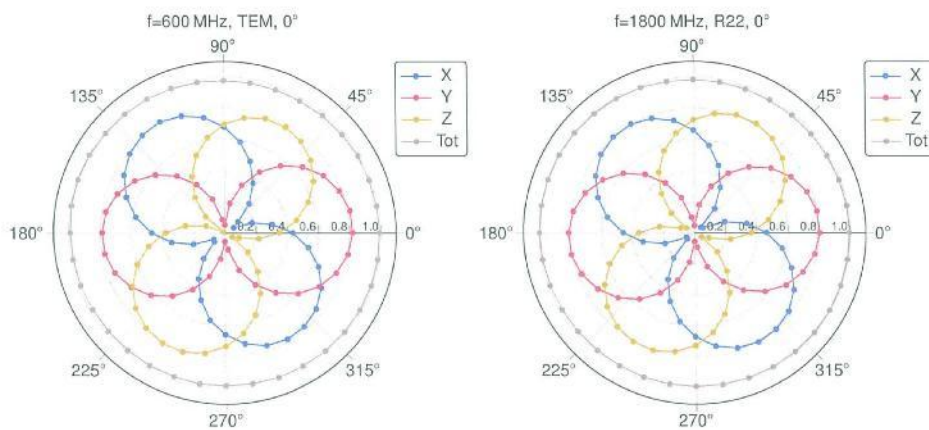


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

EX3DV4 - SN:3959

October 09, 2025

Receiving Pattern (ϕ), $\vartheta = 0^\circ$

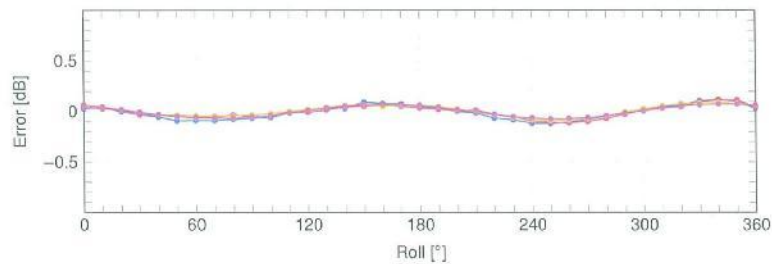
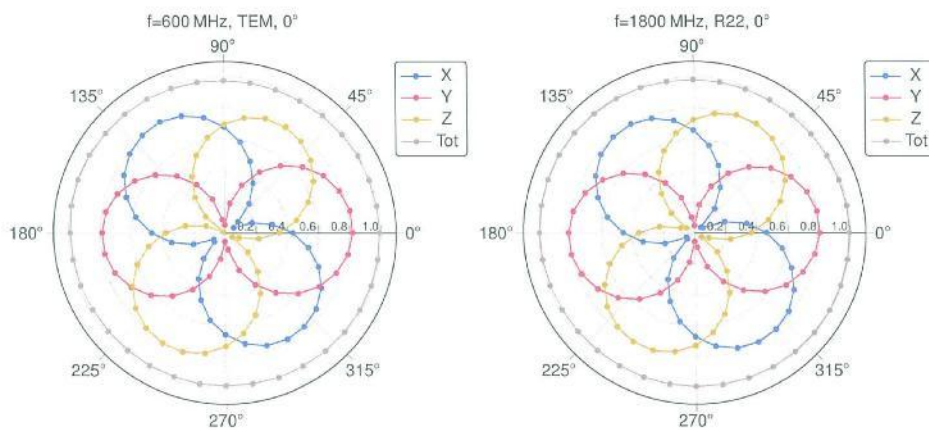


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

EX3DV4 - SN:3959

October 09, 2025

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



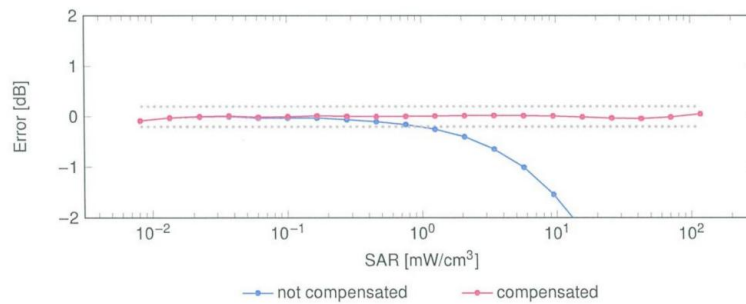
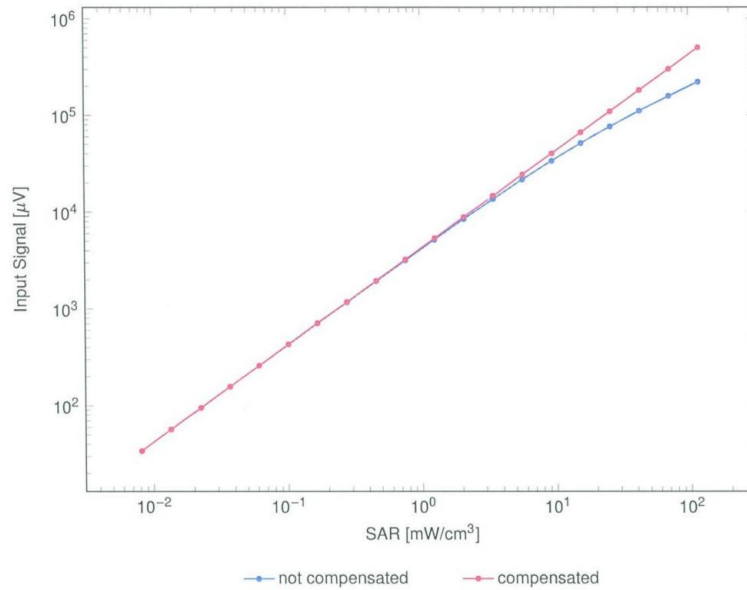
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

EX3DV4 - SN:3959

October 09, 2025

Dynamic Range $f(\text{SAR}_{\text{HSL}})$

(TEM cell, $f_{\text{eval}} = 1900 \text{ MHz}$)



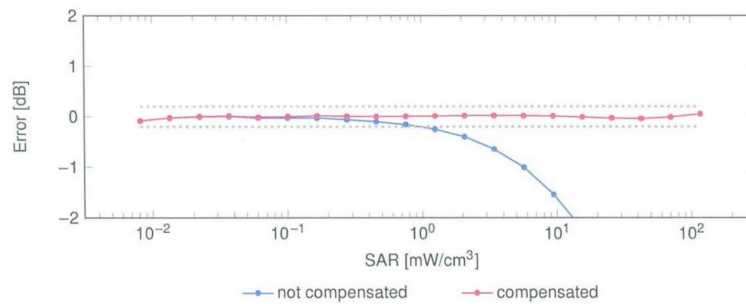
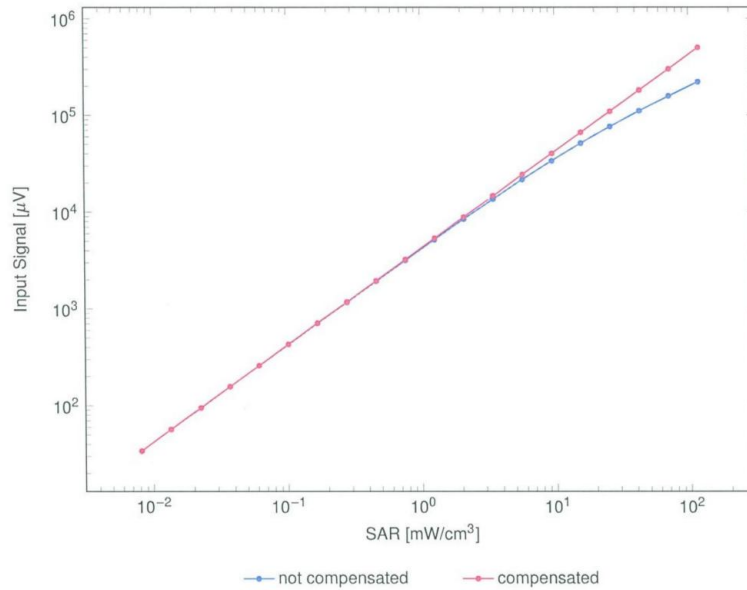
Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

EX3DV4 - SN:3959

October 09, 2025

Dynamic Range $f(\text{SAR}_{\text{HSL}})$

(TEM cell, $f_{\text{eval}} = 1900 \text{ MHz}$)

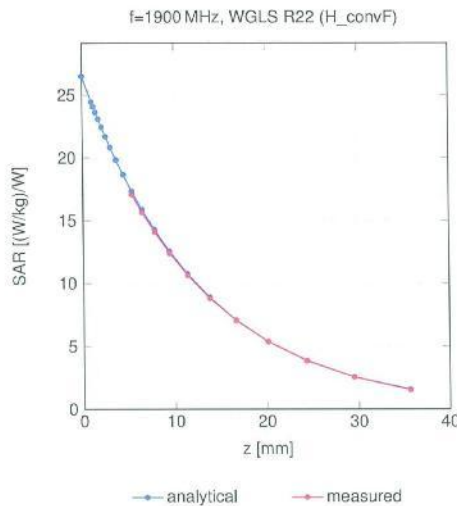


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

EX3DV4 - SN:3959

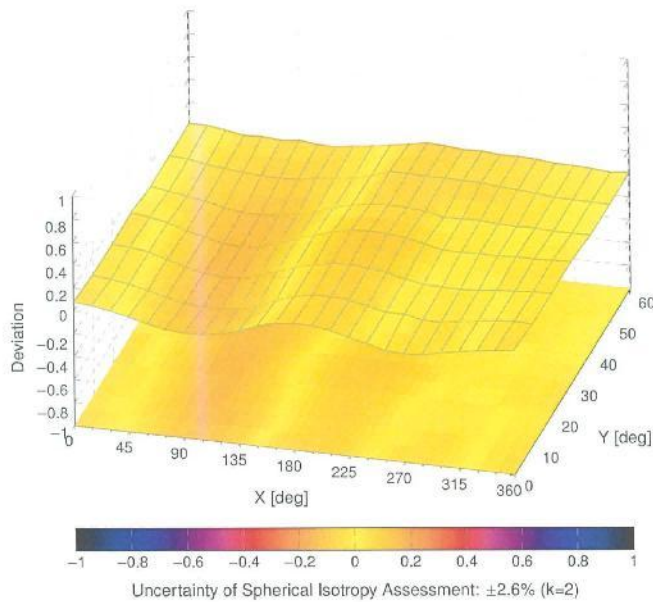
October 09, 2025

Conversion Factor Assessment



Deviation from Isotropy in Liquid

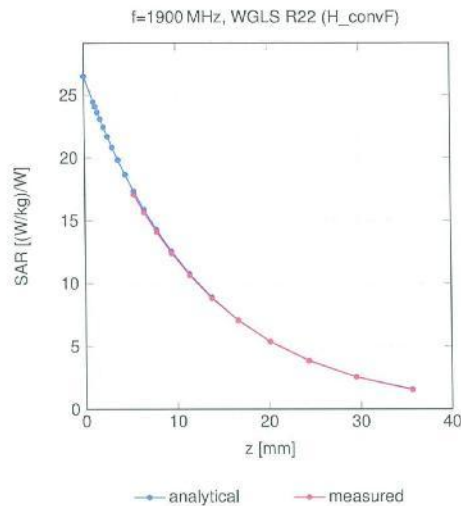
Error (ϕ, θ), f = 900 MHz



EX3DV4 - SN:3959

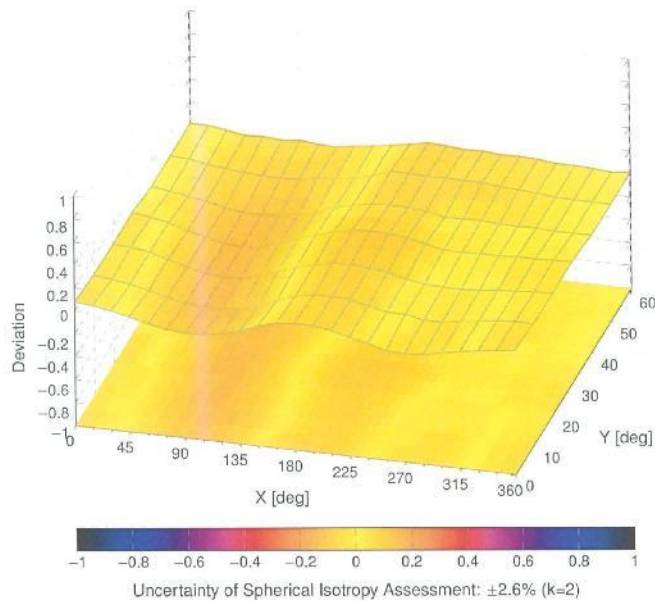
October 09, 2025

Conversion Factor Assessment



Deviation from Isotropy in Liquid

Error (ϕ, θ), f = 900 MHz



3、D750V3-SN:1214:Due Date(2028-03-31)

 In Collaboration with s p e a g CALIBRATION LABORATORY		  中国认可 国际互认 校准 CALIBRATION CNAS L0570
Add: No.52 HuaYuanBei Road, Haidian District, Beijing, 100191 Tel: +86-10-62304633-2117 E-mail: emf@caict.ac.cn http://www.caict.ac.cn		
Client: SGS		Certificate No: 25J02Z000195
CALIBRATION CERTIFICATE		
Object	D750V3 - SN: 1214	
Calibration Procedure(s)	FF-Z11-003-01 Calibration Procedures for dipole validation kits	
Calibration date:	April 1, 2025	
This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.		
All calibrations have been conducted in the closed laboratory facility: environment temperature (22±3)°C and humidity<70%.		
Calibration Equipment used (M&TE critical for calibration)		
Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)
Power Meter NRP2	106276	17-May-24 (CTTL, No. J24X04107)
Power sensor NRP6A	101369	17-May-24 (CTTL, No. J24X04107)
Reference Probe EX3DV4	SN 7307	24-May-24(SPEAG, No. EX-7307_May24)
DAE4	SN 1588	13-Sep-24(CTTL-SPEAG, No. 24J02Z000713)
Scheduled Calibration		
		May-25
		May-25
		May-25
		Sep-25
Secondary Standards	ID #	Cal Date (Calibrated by, Certificate No.)
Signal Generator E4438C	MY49071430	19-Dec-24 (CTTL, No. 24J02X103931)
NetworkAnalyzer E5071C	MY46110673	18-Dec-24 (CTTL, No. 24J02X103932)
OCP DAKS	SN 0015	09-Oct-24(SPEAG, No. OCP-DAKS-0015_Oct24)
Scheduled Calibration		
		Dec-25
		Dec-25
		Oct -25
Calibrated by:	Name Zhao Jing	Function SAR Test Engineer
Reviewed by:	Lin Jun	SAR Test Engineer
Approved by:	Qi Dianyuan	SAR Project Leader
Issued: April 8, 2025 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.		

Certificate No: 25J02Z000195

Page 1 of 6

Shenzhen Anbotek Compliance Laboratory Limited

Any unauthorized modification, forgery, or falsification of this document constitutes a violation of law and is subject to legal penalties. If you have any questions, you may scan the QR code to download the report for verification or contact us via email.

Hotline: 400-003-0500 web: www.anbotek.com E-mail: service@anbotek.com



In Collaboration with
s p e a g
CALIBRATION LABORATORY



Add: No.52 HuaYuanBei Road, Haidian District, Beijing, 100191, China

Tel: +86-10-62304633-2117

E-mail: emf@caict.ac.cn

http://www.caict.ac.cn

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM _{x,y,z}
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEC/IEEE 62209-1528, "Measurement Procedure for The Assessment of Specific Absorption Rate of Human Exposure to Radio Frequency Fields from Hand-held and Body-mounted Wireless Communication Devices- Part 1528: Human Models, Instrumentation and Procedures (Frequency range of 4 MHz to 10 GHz)", October 2020
- b) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

- c) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- **Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- **Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- **Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- **Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- **SAR measured:** SAR measured at the stated antenna input power.
- **SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- **SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.



In Collaboration with
s p e a g
CALIBRATION LABORATORY



Add: No.52 HuaYuanBei Road, Haidian District, Beijing, 100191, China
Tel: +86-10-62304633-2117
E-mail: cmf@caict.ac.cn <http://www.caict.ac.cn>

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY52	V52.10.4
Extrapolation	Advanced Extrapolation	
Phantom	Triple Flat Phantom 5.1C	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	750 MHz $\pm$ 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.9	0.89 mho/m
Measured Head TSL parameters	(22.0 $\pm$ 0.2) °C	42.0 $\pm$ 6 %	0.91 mho/m $\pm$ 6 %
Head TSL temperature change during test	<1.0 °C	—	—

SAR result with Head TSL

SAR averaged over 1 cm^3 (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.17 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	8.54 W/kg $\pm$ 18.8 % ($k=2$)
SAR averaged over 10 cm^3 (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	1.47 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	5.80 W/kg $\pm$ 18.7 % ($k=2$)



In Collaboration with

s p e a g
CALIBRATION LABORATORY

Add: No.52 HuaYuanBei Road, Haidian District, Beijing, 100191, China

Tel: +86-10-62304633-2117

E-mail: emf@caict.ac.cn

<http://www.caict.ac.cn>**Appendix (Additional assessments outside the scope of CNAS L0570)****Antenna Parameters with Head TSL**

Impedance, transformed to feed point	50.7Ω- 3.08jΩ
Return Loss	- 30.1dB

General Antenna Parameters and Design

Electrical Delay (one direction)	0.941 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feed-point can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feed-point may be damaged.

Additional EUT Data

Manufactured by	SPEAG
-----------------	-------



Add: No.52 HuaYuanBei Road, Haidian District, Beijing, 100191, China
Tel: +86-10-62304633-2117
E-mail: emf@caict.ac.cn <http://www.caict.ac.cn>

**DASY5 Validation Report for Head TSL**

Date: 2025-04-01

Test Laboratory: CTTL, Beijing, China

DUT: Dipole 750 MHz; Type: D750V3; Serial: D750V3 - SN: 1214

Communication System: UID 0, CW; Frequency: 750 MHz

Medium parameters used: $f = 750 \text{ MHz}$; $\sigma = 0.91 \text{ S/m}$; $\epsilon_r = 42.04$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Right Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: EX3DV4 - SN7307; ConvF(9.25, 9.17, 10.18) @ 750 MHz; Calibrated: 2024-05-28
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn1588; Calibrated: 2024-09-13
- Phantom: MFP_V5.1C (20deg probe tilt); Type: QD 000 P51 Cx; Serial: 1062
- DASY52 52.10.4(1535); SEMCAD X 14.6.14(7501)

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$, $dz=5\text{mm}$

Reference Value = 55.64 V/m; Power Drift = -0.01 dB

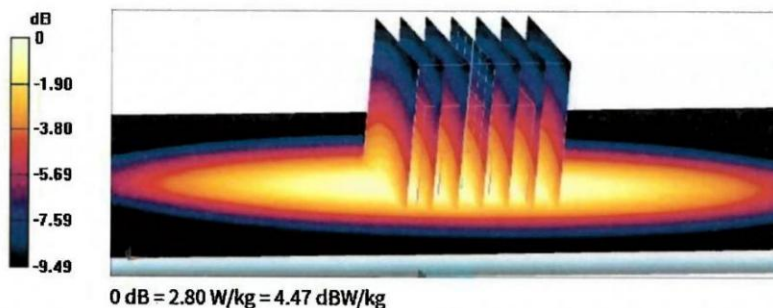
Peak SAR (extrapolated) = 3.07 W/kg

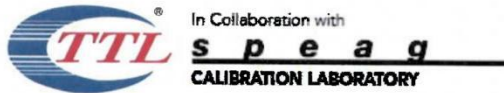
SAR(1 g) = 2.17 W/kg; SAR(10 g) = 1.47 W/kg

Smallest distance from peaks to all points 3 dB below = 18 mm

Ratio of SAR at M2 to SAR at M1 = 70.7%

Maximum value of SAR (measured) = 2.80 W/kg

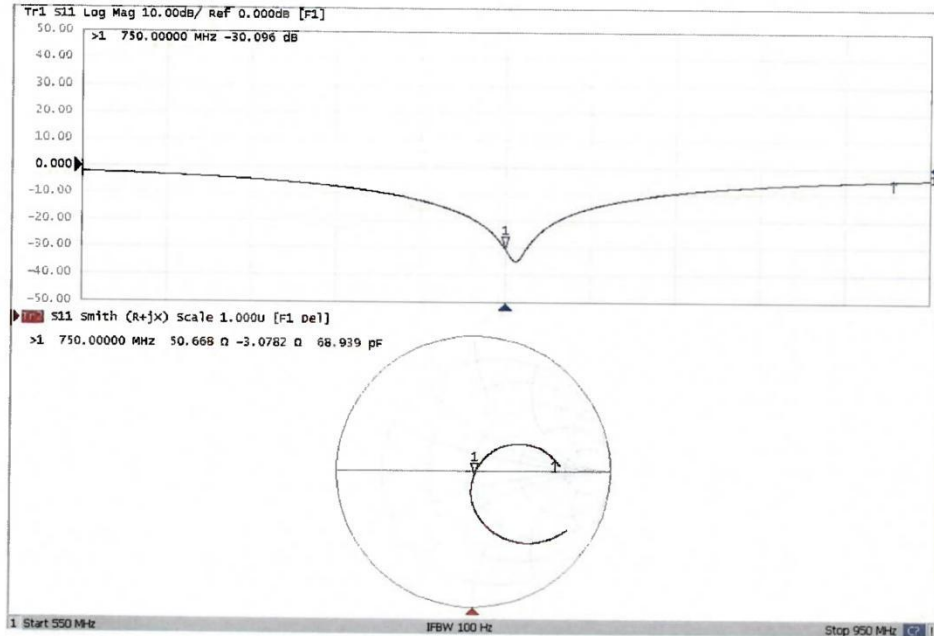




Add: No.52 HuaYuanBei Road, Haidian District, Beijing, 100191, China
Tel: +86-10-62304633-2117
E-mail: emf@caict.ac.cn <http://www.caict.ac.cn>



Impedance Measurement Plot for Head TSL



4、D835V3-SN:4d164:Due Date(2028-09-17)

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland			S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage S Servizio svizzero di taratura S Swiss Calibration Service
Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates	Accreditation No.: SCS 0108		

Client Anbotek Shenzhen	Certificate No. D835V2-4d164_Sep25
--	---

CALIBRATION CERTIFICATE

Object	D835V2 - SN: 4d164
Calibration procedure(s)	QA CAL-05.v12 Calibration Procedure for SAR Validation Sources between 0.7 - 3 GHz
Calibration date	September 18, 2025

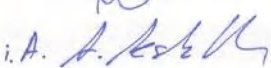
This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Cal
Power Sensor R&S NRP-33T	SN: 100967	30-Apr-25 (No. 1020-300791789)	Apr-26
Power Sensor R&S NRP18A	SN: 101859	06-Feb-25 (No. 4030A315009541)	Feb-26
Spectrum Analyzer R&S FSV40	SN: 101832	29-Jan-25 (No. 4030A315009658)	Jan-26
3.5mm mismatch combination	SN: 1152	24-Mar-25 (No. 217-04293)	Mar-26
OCP DAK-12	SN: 1016	16-Sept-25 (No. OCP-DAK12-1016_Sep25)	Sep-26
OCP DAK-3.5	SN: 1249	16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)	Sep-26
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4ip	SN: 1836	04-Sep-25 (No. DAE4ip-1836_Sep25)	Sep-26

Secondary Standards	ID	Check Date (in house)	Scheduled Check
ACAD Setup 1	SN: 1000	27-May-25 (No. 675-ACAD_Source_Box-250527)	May-26
Signal Generator R&S SMB100A	SN: 182081	27-May-25 (No. 675-CAL16-S4588-250527)	May-26
Mismatch; SMA	SN: 1102	24-Apr-25 (No. 675-Mismatch_SMA-250424)	Apr-26
OCP DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26
OCP DAK-3.5	SN: 1336	09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)	Dec-25

Calibrated by Approved by	Name Claudio Leubler Sven Kühn	Function Laboratory Technician Technical Manager	Signature  
--------------------------------------	--	--	---

Issued: September 19, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: D835V2-4d164_Sep25	Page 1 of 6
------------------------------------	-------------

Shenzhen Anbotek Compliance Laboratory Limited

Any unauthorized modification, forgery, or falsification of this document constitutes a violation of law and is subject to legal penalties. If you have any questions, you may scan the QR code to download the report for verification or contact us via email.

Hotline: 400-003-0500 web: www.anbotek.com E-mail: service@anbotek.com

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Glossary

TSL tissue simulating liquid
ConvF sensitivity in TSL / NORM x,y,z
N/A not applicable or not measured

Calibration is Performed According to the Following Standards

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices - Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation

- DASY System Handbook

Methods Applied and Interpretation of Parameters

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

D835V2 - SN: 4d164

September 18, 2025

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY8 Module SAR	17.0.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	15 mm	with spacer
Zoom Scan Resolution	dx, dy = 6mm, dz = 1.5mm	Graded Ratio = 1.5 mm (Z direction)
Frequency	835MHz $\pm$ 1MHz	

HSL parameters at 835 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal HSL parameters	22.0 °C	41.5	0.900 mho/m
Measured HSL parameters	(22.0 $\pm$ 0.2)°C	42.4 $\pm$ 6%	0.930 mho/m $\pm$ 6%
HSL temperature change during test	< 0.5 °C		

SAR result with HSL at 835 MHz

SAR averaged over 1 cm ³ (1 g) of HSL	Condition	
SAR for nominal HSL parameters	24 dBm input power	2.37 W/kg
SAR for nominal HSL parameters	normalized to 1W	9.44 W/kg $\pm$ 17.0% (k = 2)

SAR averaged over 10 cm ³ (10 g) of HSL	Condition	
SAR for nominal HSL parameters	24 dBm input power	1.53 W/kg
SAR for nominal HSL parameters	normalized to 1W	6.09 W/kg $\pm$ 16.5% (k = 2)

D835V2 - SN: 4d164

September 18, 2025

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters with HSL at 835 MHz

Impedance	51.2 Ω - 2.9 j Ω
Return Loss	-30.2 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.432 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured. The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
-----------------	-------

D835V2 - SN: 4d164

September 18, 2025

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D835V2 - SN4d164	835	HSL	24

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	15	CW, 0---	835, 0		9.51	0.93	42.4

Hardware Setup

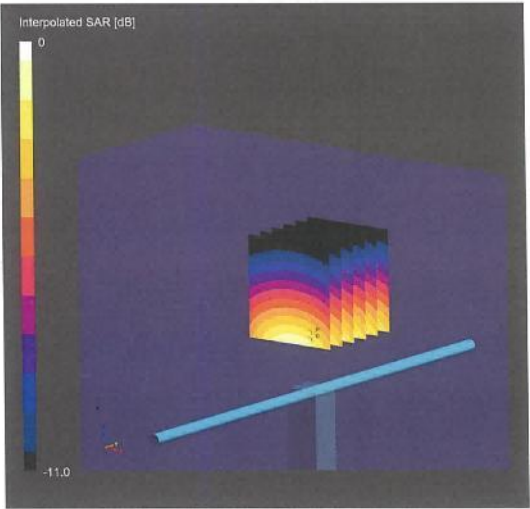
Phantom	TSL, Measured Date	Probe, Calibration Date	DAF, Calibration Date
Flat V4.9 mod	HSL, 2025-09-18	EX3DV4 - SN7349, 2025-01-10	DAE4ip Sn1836, 2025-09-04

Scans Setup

	Zoom Scan
Grid Extents [mm]	30 x 30 x 30
Grid Steps [mm]	6.0 x 6.0 x 1.5
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.5
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

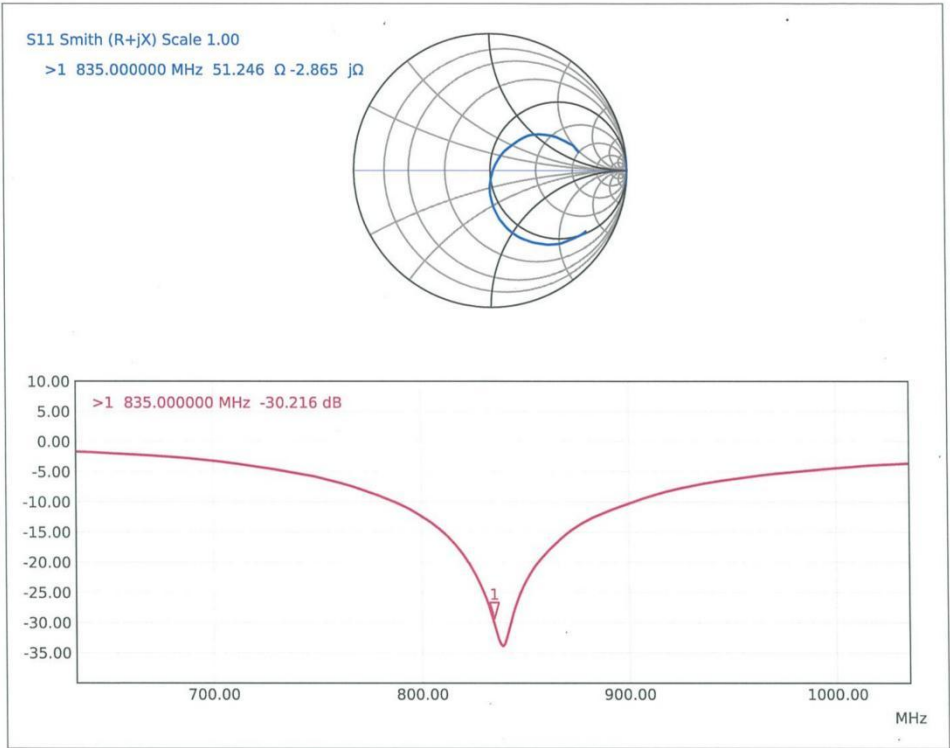
	Zoom Scan
Date	2025-09-18
psSAR1g [W/Kg]	2.37
psSAR10g [W/Kg]	1.53
Power Drift [dB]	0.01
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



D835V2 - SN: 4d164

September 18, 2025

Impedance Measurement Plot for HSL



5、D1750V2-SN:1107:Due Date(2028-09-16)

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates			S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage S Servizio svizzero di taratura S Swiss Calibration Service Accreditation No.: SCS 0108																																				
Client: Anbotek Shenzhen	Certificate No. D1750V2-1107_Sep25																																						
CALIBRATION CERTIFICATE																																							
Object: D1750V2 - SN: 1107 Calibration procedure(s): QA CAL-05.v12 Calibration Procedure for SAR Validation Sources between 0.7 - 3 GHz Calibration date: September 17, 2025 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22±3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration)																																							
<table border="1" style="width:100%; border-collapse: collapse; font-size: 0.9em;"> <thead> <tr> <th>Primary Standards</th> <th>ID</th> <th>Cal Date (Certificate No.)</th> <th>Scheduled Cal</th> </tr> </thead> <tbody> <tr> <td>Power Sensor R&S NRP-33T</td> <td>SN: 100967</td> <td>30-Apr-25 (No. 1020-300791789)</td> <td>Apr-26</td> </tr> <tr> <td>Power Sensor R&S NRP18A</td> <td>SN: 101859</td> <td>06-Feb-25 (No. 4030A315009541)</td> <td>Feb-26</td> </tr> <tr> <td>Spectrum Analyzer R&S FSV40</td> <td>SN: 101832</td> <td>29-Jan-25 (No. 4030A315009658)</td> <td>Jan-26</td> </tr> <tr> <td>3.5mm mismatch combination</td> <td>SN: 1152</td> <td>24-Mar-25 (No. 217-04293)</td> <td>Mar-26</td> </tr> <tr> <td>OCP DAK-12</td> <td>SN: 1016</td> <td>16-Sept-25 (No. OCP-DAK12-1016_Sep25)</td> <td>Sep-26</td> </tr> <tr> <td>OCP DAK-3.5</td> <td>SN: 1249</td> <td>16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)</td> <td>Sep-26</td> </tr> <tr> <td>Reference Probe EX3DV4</td> <td>SN: 7349</td> <td>10-Jan-25 (No. EX3-7349_Jan25)</td> <td>Jan-26</td> </tr> <tr> <td>DAE4ip</td> <td>SN: 1836</td> <td>04-Sep-25 (No. DAE4ip-1836_Sep25)</td> <td>Sep-26</td> </tr> </tbody> </table>				Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Cal	Power Sensor R&S NRP-33T	SN: 100967	30-Apr-25 (No. 1020-300791789)	Apr-26	Power Sensor R&S NRP18A	SN: 101859	06-Feb-25 (No. 4030A315009541)	Feb-26	Spectrum Analyzer R&S FSV40	SN: 101832	29-Jan-25 (No. 4030A315009658)	Jan-26	3.5mm mismatch combination	SN: 1152	24-Mar-25 (No. 217-04293)	Mar-26	OCP DAK-12	SN: 1016	16-Sept-25 (No. OCP-DAK12-1016_Sep25)	Sep-26	OCP DAK-3.5	SN: 1249	16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)	Sep-26	Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26	DAE4ip	SN: 1836	04-Sep-25 (No. DAE4ip-1836_Sep25)	Sep-26
Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Cal																																				
Power Sensor R&S NRP-33T	SN: 100967	30-Apr-25 (No. 1020-300791789)	Apr-26																																				
Power Sensor R&S NRP18A	SN: 101859	06-Feb-25 (No. 4030A315009541)	Feb-26																																				
Spectrum Analyzer R&S FSV40	SN: 101832	29-Jan-25 (No. 4030A315009658)	Jan-26																																				
3.5mm mismatch combination	SN: 1152	24-Mar-25 (No. 217-04293)	Mar-26																																				
OCP DAK-12	SN: 1016	16-Sept-25 (No. OCP-DAK12-1016_Sep25)	Sep-26																																				
OCP DAK-3.5	SN: 1249	16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)	Sep-26																																				
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26																																				
DAE4ip	SN: 1836	04-Sep-25 (No. DAE4ip-1836_Sep25)	Sep-26																																				
<table border="1" style="width:100%; border-collapse: collapse; font-size: 0.9em;"> <thead> <tr> <th>Secondary Standards</th> <th>ID</th> <th>Check Date (in house)</th> <th>Scheduled Check</th> </tr> </thead> <tbody> <tr> <td>ACAD Setup 1</td> <td>SN: 1000</td> <td>27-May-25 (No. 675-ACAD_Source_Box-250527)</td> <td>May-26</td> </tr> <tr> <td>Signal Generator R&S SMB100A</td> <td>SN: 182081</td> <td>27-May-25 (No. 675-CAL16-S4588-250527)</td> <td>May-26</td> </tr> <tr> <td>Mismatch; SMA</td> <td>SN: 1102</td> <td>24-Apr-25 (No. 675-Mismatch_SMA-250424)</td> <td>Apr-26</td> </tr> <tr> <td>OCP DAK-12</td> <td>SN: 1029</td> <td>27-Feb-25 (No. OCP-DAK12-1029_Feb25)</td> <td>Feb-26</td> </tr> <tr> <td>OCP DAK-3.5</td> <td>SN: 1336</td> <td>09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)</td> <td>Dec-25</td> </tr> </tbody> </table>				Secondary Standards	ID	Check Date (in house)	Scheduled Check	ACAD Setup 1	SN: 1000	27-May-25 (No. 675-ACAD_Source_Box-250527)	May-26	Signal Generator R&S SMB100A	SN: 182081	27-May-25 (No. 675-CAL16-S4588-250527)	May-26	Mismatch; SMA	SN: 1102	24-Apr-25 (No. 675-Mismatch_SMA-250424)	Apr-26	OCP DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26	OCP DAK-3.5	SN: 1336	09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)	Dec-25												
Secondary Standards	ID	Check Date (in house)	Scheduled Check																																				
ACAD Setup 1	SN: 1000	27-May-25 (No. 675-ACAD_Source_Box-250527)	May-26																																				
Signal Generator R&S SMB100A	SN: 182081	27-May-25 (No. 675-CAL16-S4588-250527)	May-26																																				
Mismatch; SMA	SN: 1102	24-Apr-25 (No. 675-Mismatch_SMA-250424)	Apr-26																																				
OCP DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26																																				
OCP DAK-3.5	SN: 1336	09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)	Dec-25																																				
<table style="width:100%;"> <tr> <td style="width:30%;"></td> <td style="width:20%;">Name</td> <td style="width:20%;">Function</td> <td style="width:30%;">Signature</td> </tr> <tr> <td>Calibrated by</td> <td>Claudio Leubler</td> <td>Laboratory Technician</td> <td></td> </tr> <tr> <td>Approved by</td> <td>Sven Kühn</td> <td>Technical Manager</td> <td></td> </tr> </table> Issued: September 17, 2025 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.					Name	Function	Signature	Calibrated by	Claudio Leubler	Laboratory Technician		Approved by	Sven Kühn	Technical Manager																									
	Name	Function	Signature																																				
Calibrated by	Claudio Leubler	Laboratory Technician																																					
Approved by	Sven Kühn	Technical Manager																																					

Certificate No: D1750V2-1107_Sep25

Page 1 of 6

Shenzhen Anbotek Compliance Laboratory Limited

Any unauthorized modification, forgery, or falsification of this document constitutes a violation of law and is subject to legal penalties. If you have any questions, you may scan the QR code to download the report for verification or contact us via email.

Hotline: 400-003-0500 web: www.anbotek.com E-mail: service@anbotek.com

Calibration Laboratory of
Schmid & Partner
Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Glossary

TSL tissue simulating liquid
ConvF sensitivity in TSL / NORM x,y,z
N/A not applicable or not measured

Calibration is Performed According to the Following Standards

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices - Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation

- DASY System Handbook

Methods Applied and Interpretation of Parameters

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

D1750V2 - SN: 1107

September 17, 2025

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY8 Module SAR	17.0.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with spacer
Zoom Scan Resolution	dx, dy = 6mm, dz = 1.5mm	Graded Ratio = 1.5 mm (Z direction)
Frequency	1750MHz $\pm$ 1MHz	

HSL parameters at 1750 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal HSL parameters	22.0 °C	40.1	1.37 mho/m
Measured HSL parameters	(22.0 $\pm$ 0.2)°C	40.7 $\pm$ 6%	1.36 mho/m $\pm$ 6%
HSL temperature change during test	< 0.5 °C		

SAR result with HSL at 1750 MHz

SAR averaged over 1 cm ³ (1 g) of HSL	Condition	
SAR for nominal HSL parameters	24 dBm input power	9.18 W/kg
SAR for nominal HSL parameters	normalized to 1W	36.5 W/kg $\pm$ 17.0% (k = 2)

SAR averaged over 10 cm ³ (10 g) of HSL	Condition	
SAR for nominal HSL parameters	24 dBm input power	4.88 W/kg
SAR for nominal HSL parameters	normalized to 1W	19.4 W/kg $\pm$ 16.5% (k = 2)

D1750V2 - SN: 1107

September 17, 2025

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters with HSL at 1750 MHz

Impedance	50.9 Ω – 1.0 j Ω
Return Loss	-37.7 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.22 ns
----------------------------------	---------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured. The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
-----------------	-------

D1750V2 - SN: 1107

September 17, 2025

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D1750V2 - SN1107	1750	HSL	24

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10	CW, 0--		1750, 0	7.96	1.36	40.7

Hardware Setup

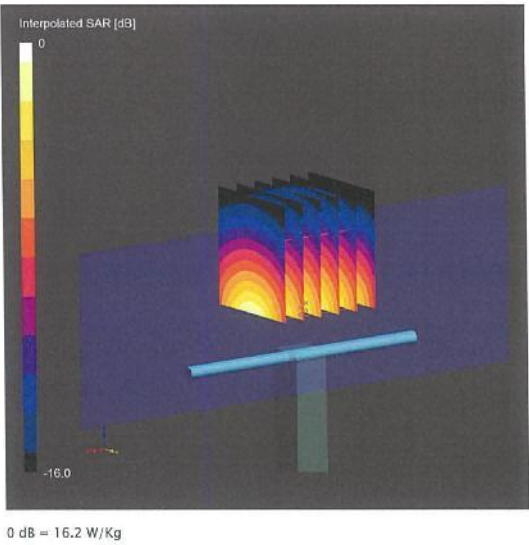
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2025-09-17	EX3DV4 - SN7349, 2025-01-10	DAE4ip Sn1836, 2025-09-04

Scans Setup

	Zoom Scan
Grid Extents [mm]	30 x 30 x 30
Grid Steps [mm]	6.0 x 6.0 x 1.5
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.5
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

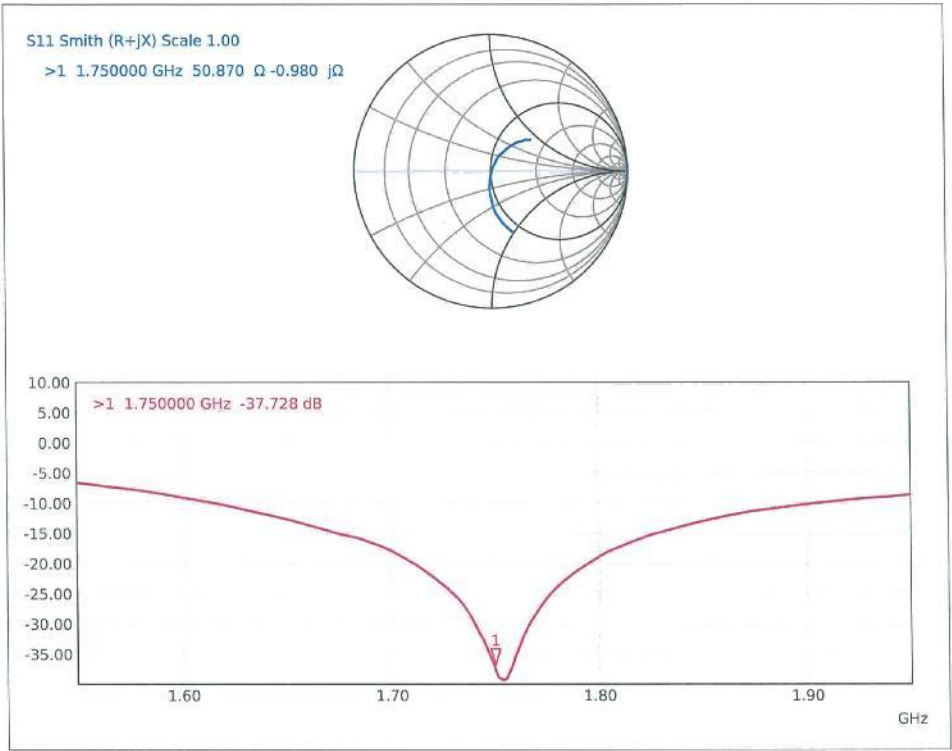
	Zoom Scan
Date	2025-09-17
psSAR1g [W/Kg]	9.18
psSAR10g [W/Kg]	4.88
Power Drift [dB]	0.01
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



D1750V2 - SN: 1107

September 17, 2025

Impedance Measurement Plot for HSL



6、D1900V2-SN:5d089:Due Date(2028-09-16)

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland			S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage S Servizio svizzero di taratura S Swiss Calibration Service
Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates	Accreditation No.: SCS 0108		

Client Anbotek Shenzhen	Certificate No. D1900V2-5d089_Sep25
-----------------------------------	--

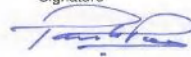
CALIBRATION CERTIFICATE

Object	D1900V2 - SN: 5d089
Calibration procedure(s)	QA CAL-05.v12 Calibration Procedure for SAR Validation Sources between 0.7 - 3 GHz
Calibration date	September 17, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.
All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.
Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Cal
Power Sensor R&S NRP-33T	SN: 100967	30-Apr-25 (No. 1020-300791789)	Apr-26
Power Sensor R&S NRP18A	SN: 101859	06-Feb-25 (No. 4030A315009541)	Feb-26
Spectrum Analyzer R&S FSV40	SN: 101832	29-Jan-25 (No. 4030A315009658)	Jan-26
3.5mm mismatch combination	SN: 1152	24-Mar-25 (No. 217-04293)	Mar-26
OCP DAK-12	SN: 1016	16-Sept-25 (No. OCP-DAK12-1016_Sep25)	Sep-26
OCP DAK-3.5	SN: 1249	16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)	Sep-26
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4ip	SN: 1836	04-Sep-25 (No. DAE4ip-1836_Sep25)	Sep-26

Secondary Standards	ID	Check Date (in house)	Scheduled Check
ACAD Setup 1	SN: 1000	27-May-25 (No. 675-ACAD_Source_Box-250527)	May-26
Signal Generator R&S SMB100A	SN: 182081	27-May-25 (No. 675-CAL16-S4588-250527)	May-26
Mismatch; SMA	SN: 1102	24-Apr-25 (No. 675-Mismatch_SMA-250424)	Apr-26
OCP DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26
OCP DAK-3.5	SN: 1336	09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)	Dec-25

	Name	Function	Signature
Calibrated by	Paulo Pina	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	

Issued: September 17, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: D1900V2-5d089_Sep25	Page 1 of 6
-------------------------------------	-------------

Shenzhen Anbotek Compliance Laboratory Limited

Any unauthorized modification, forgery, or falsification of this document constitutes a violation of law and is subject to legal penalties. If you have any questions, you may scan the QR code to download the report for verification or contact us via email.

Hotline: 400-003-0500 web: www.anbotek.com E-mail: service@anbotek.com

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Glossary

TSL tissue simulating liquid
ConvF sensitivity in TSL / NORM x,y,z
N/A not applicable or not measured

Calibration is Performed According to the Following Standards

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices - Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation

- DASY System Handbook

Methods Applied and Interpretation of Parameters

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

D1900V2 - SN: 5d089

September 17, 2025

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY8 Module SAR	17.0.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with spacer
Zoom Scan Resolution	dx, dy = 6mm, dz = 1.5mm	Graded Ratio = 1.5 mm (Z direction)
Frequency	1900MHz $\pm$ 1MHz	

HSL parameters at 1900 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal HSL parameters	22.0 °C	40.0	1.40 mho/m
Measured HSL parameters	(22.0 $\pm$ 0.2)°C	40.8 $\pm$ 6%	1.39 mho/m $\pm$ 6%
HSL temperature change during test	< 0.5 °C		

SAR result with HSL at 1900 MHz

SAR averaged over 1 cm ³ (1 g) of HSL	Condition	
SAR for nominal HSL parameters	24 dBm input power	9.91 W/kg
SAR for nominal HSL parameters	normalized to 1W	39.5 W/kg $\pm$ 17.0% (k = 2)

SAR averaged over 10 cm ³ (10 g) of HSL	Condition	
SAR for nominal HSL parameters	24 dBm input power	5.24 W/kg
SAR for nominal HSL parameters	normalized to 1W	20.9 W/kg $\pm$ 16.5% (k = 2)

D1900V2 - SN: 5d089

September 17, 2025

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters with HSL at 1900 MHz

Impedance	51.9 Ω + 9.2 j Ω
Return Loss	-20.8 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.19 ns
----------------------------------	---------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured. The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
-----------------	-------

D1900V2 - SN: 5d089

September 17, 2025

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D1900V2 - SN5d089	1900	HSL	24

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10	CW, 0--		1900, 0	7.68	1.39	40.8

Hardware Setup

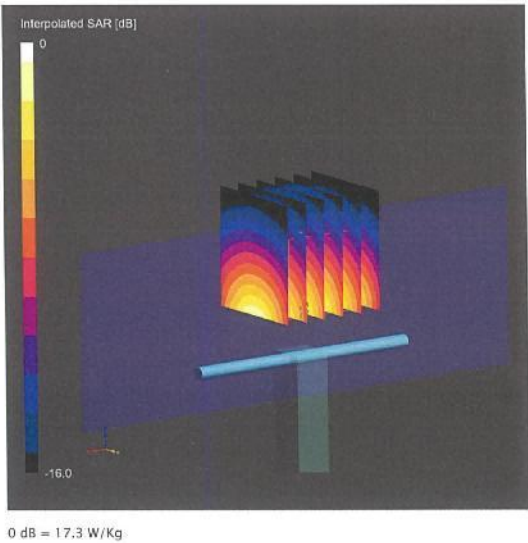
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2025-09-17	EX3DV4 - SN7349, 2025-01-10	DAE4lp Sn1836, 2025-09-04

Scans Setup

	Zoom Scan
Grid Extents [mm]	30 x 30 x 30
Grid Steps [mm]	6.0 x 6.0 x 1.5
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.5
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

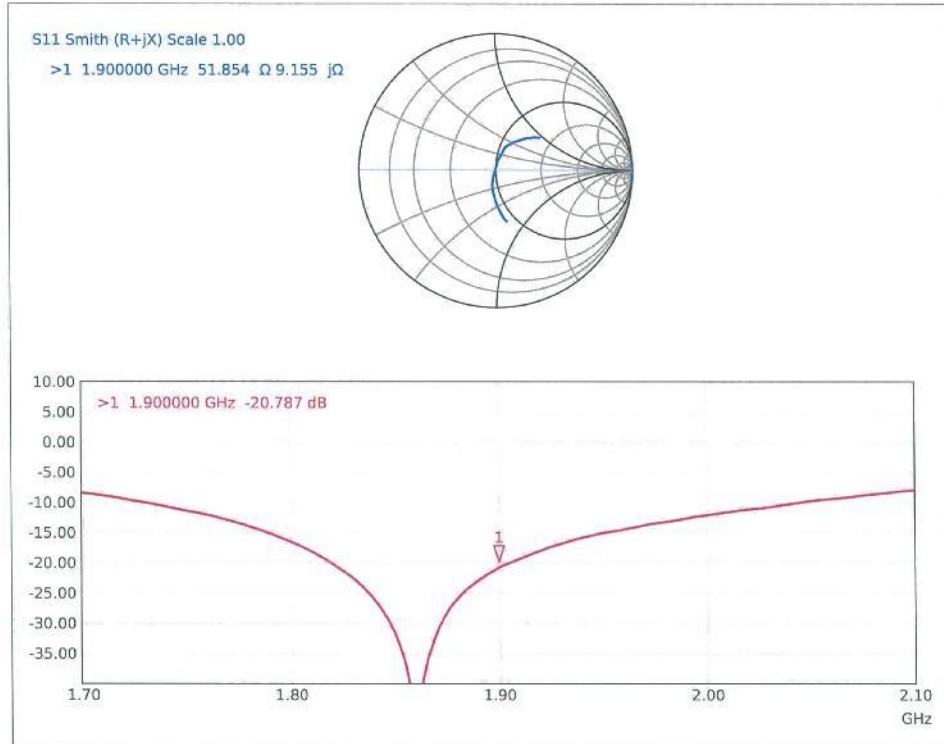
	Zoom Scan
Date	2025-09-17
psSAR1g [W/Kg]	9.91
psSAR10g [W/Kg]	5.24
Power Drift [dB]	0.01
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



D1900V2 - SN: 5d089

September 17, 2025

Impedance Measurement Plot for HSL



7、D2450V2-SN:1018:Due Date(2028-09-15)

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland			S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage S Servizio svizzero di taratura S Swiss Calibration Service
Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates			Accreditation No.: SCS 0108

Client	Anbotek Shenzhen	Certificate No.	D2450V2-1018_Sep25
--------	----------------------------	-----------------	---------------------------

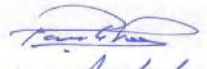
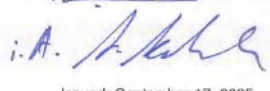
CALIBRATION CERTIFICATE

Object	D2450V2 - SN: 1018
Calibration procedure(s)	QA CAL-05.v12 Calibration Procedure for SAR Validation Sources between 0.7 - 3 GHz
Calibration date	September 16, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.
 All calibrations have been conducted in the closed laboratory facility: environment temperature (22±3)°C and humidity < 70%.
 Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Cal
Power Sensor R&S NRP-33T	SN: 100967	30-Apr-25 (No. 1020-300791789)	Apr-26
Power Sensor R&S NRP18A	SN: 101859	06-Feb-25 (No. 4030A315009541)	Feb-26
Spectrum Analyzer R&S FSV40	SN: 101832	29-Jan-25 (No. 4030A315009658)	Jan-26
3.5mm mismatch combination	SN: 1152	24-Mar-25 (No. 217-04293)	Mar-26
OCP DAK-12	SN: 1016	24-Sept-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sept-24 (No. OCP-DAK3.5-1249_Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4ip	SN: 1836	04-Sep-25 (No. DAE4ip-1836_Sep25)	Sep-26

Secondary Standards	ID	Check Date (in house)	Scheduled Check
ACAD Setup 1	SN: 1000	27-May-25 (No. 675-ACAD_Source_Box-250527)	May-26
Signal Generator R&S SMB100A	SN: 182081	27-May-25 (No. 675-CAL16-S4588-250527)	May-26
Mismatch; SMA	SN: 1102	24-Apr-25 (No. 675-Mismatch_SMA-250424)	Apr-26
OCP DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26
OCP DAK-3.5	SN: 1336	09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)	Dec-25

	Name	Function	Signature
Calibrated by	Paulo Pina	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	

Issued: September 17, 2025
 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: D2450V2-1018_Sep25
Page 1 of 6

Shenzhen Anbotek Compliance Laboratory Limited

Any unauthorized modification, forgery, or falsification of this document constitutes a violation of law and is subject to legal penalties. If you have any questions, you may scan the QR code to download the report for verification or contact us via email.

Hotline: 400-003-0500 web: www.anbotek.com E-mail: service@anbotek.com

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Glossary

TSL tissue simulating liquid
ConvF sensitivity in TSL / NORM x,y,z
N/A not applicable or not measured

Calibration is Performed According to the Following Standards

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices - Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation

- DASY System Handbook

Methods Applied and Interpretation of Parameters

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

D2450V2 - SN: 1018

September 16, 2025

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY8 Module SAR	17.0.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with spacer
Zoom Scan Resolution	dx, dy = 5mm, dz = 1.5mm	Graded Ratio = 1.5 mm (Z direction)
Frequency	2450MHz $\pm$ 1MHz	

HSL parameters at 2450 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal HSL parameters	22.0 °C	39.2	1.80 mho/m
Measured HSL parameters	(22.0 $\pm$ 0.2)°C	38.0 $\pm$ 6%	1.84 mho/m $\pm$ 6%
HSL temperature change during test	< 0.5 °C		

SAR result with HSL at 2450 MHz

SAR averaged over 1 cm ³ (1 g) of HSL	Condition	
SAR for nominal HSL parameters	24 dBm input power	13.2 W/kg
SAR for nominal HSL parameters	normalized to 1W	52.6 W/kg $\pm$ 17.0% (k = 2)

SAR averaged over 10 cm ³ (10 g) of HSL	Condition	
SAR for nominal HSL parameters	24 dBm input power	6.19 W/kg
SAR for nominal HSL parameters	normalized to 1W	24.6 W/kg $\pm$ 16.5% (k = 2)

D2450V2 - SN: 1018

September 16, 2025

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters with HSL at 2450 MHz

Impedance	54.2 Ω + 1.4 j Ω
Return Loss	-27.3 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.149 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured. The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
-----------------	-------

D2450V2 - SN: 1018

September 16, 2025

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dlim]
D2450V2 - SN1018	2450	HSL	24

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10	CW, 0--		2450, 0	7.06	1.84	38.0

Hardware Setup

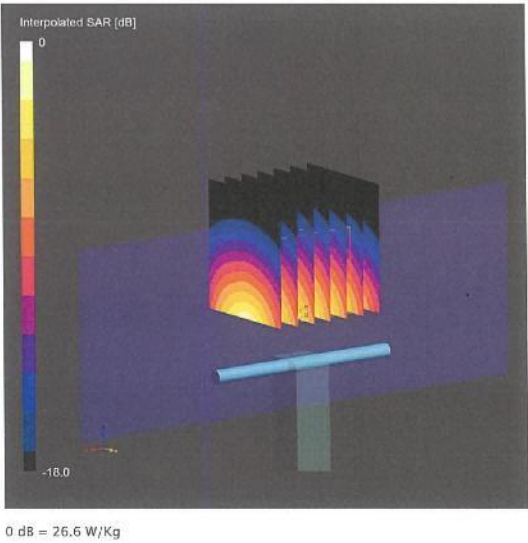
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2025-09-16	EX3DV4 - SN7349, 2025-01-10	DAE4lp Sn1836, 2025-09-04

Scans Setup

	Zoom Scan
Grid Extents [mm]	30 x 30 x 30
Grid Steps [mm]	5.0 x 5.0 x 1.5
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.5
MAIA	N/A
Surface Detection	VMS - 6p
Scan Method	Measured

Measurement Results

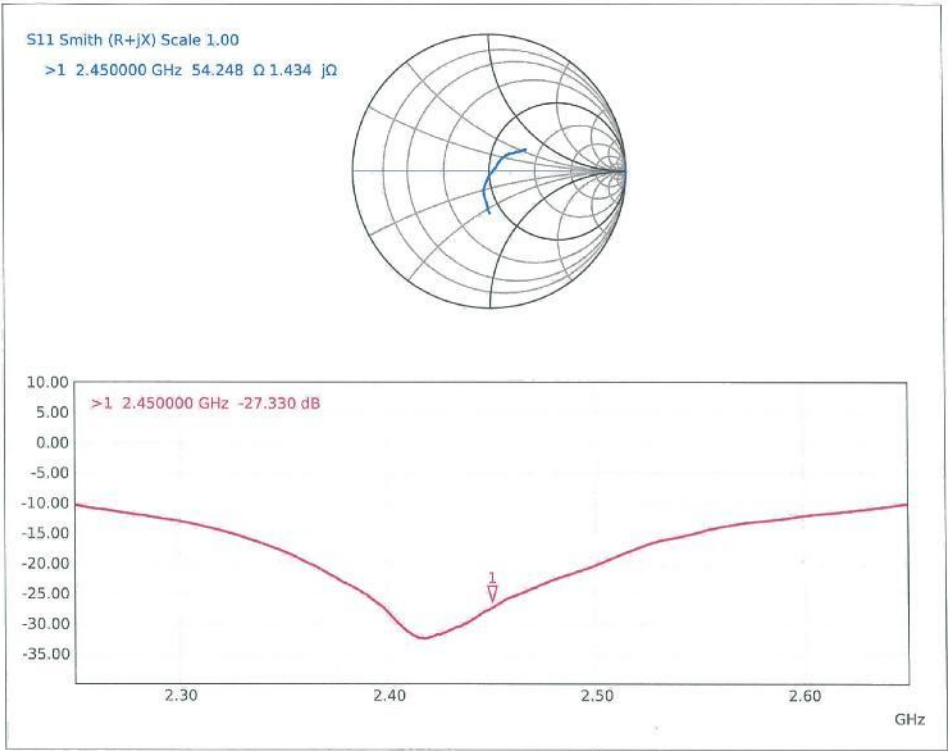
	Zoom Scan
Date	2025-09-16
psSAR1g [W/Kg]	13.2
psSAR10g [W/Kg]	6.19
Power Drift [dB]	0.02
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



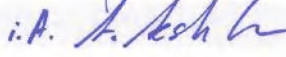
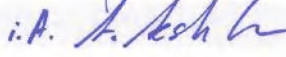
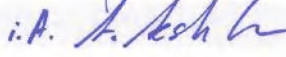
D2450V2 - SN: 1018

September 16, 2025

Impedance Measurement Plot for HSL



8、D5GHzV2-SN:1093:Due Date(2028-09-16)

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates			S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage S Servizio svizzero di taratura S Swiss Calibration Service Accreditation No.: SCS 0108																																				
Client Anbotek Shenzhen	Certificate No. D5GHzV2-1093_Sep25																																						
CALIBRATION CERTIFICATE																																							
Object D5GHzV2 - SN: 1093																																							
Calibration procedure(s) QA CAL-22.v7 Calibration Procedure for SAR Validation Sources between 3 - 10 GHz																																							
Calibration date September 17, 2025																																							
This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22±3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration)																																							
<table border="1" style="width:100%; border-collapse: collapse;"> <thead> <tr> <th>Primary Standards</th> <th>ID</th> <th>Cal Date (Certificate No.)</th> <th>Scheduled Cal</th> </tr> </thead> <tbody> <tr> <td>Power Sensor R&S NRP-33T</td> <td>SN: 100967</td> <td>30-Apr-25 (No. 1020-300791789)</td> <td>Apr-26</td> </tr> <tr> <td>Power Sensor R&S NRP18A</td> <td>SN: 101859</td> <td>06-Feb-25 (No. 4030A315009541)</td> <td>Feb-26</td> </tr> <tr> <td>Spectrum Analyzer R&S FSV40</td> <td>SN: 101832</td> <td>29-Jan-25 (No. 4030A315009658)</td> <td>Jan-26</td> </tr> <tr> <td>3.5mm mismatch combination</td> <td>SN: 1152</td> <td>24-Mar-25 (No. 217-04293)</td> <td>Mar-26</td> </tr> <tr> <td>OCP DAK-12</td> <td>SN: 1016</td> <td>16-Sept-25 (No. OCP-DAK12-1016_Sep25)</td> <td>Sep-26</td> </tr> <tr> <td>OCP DAK-3.5</td> <td>SN: 1249</td> <td>16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)</td> <td>Sep-26</td> </tr> <tr> <td>Reference Probe EX3DV4</td> <td>SN: 7349</td> <td>10-Jan-25 (No. EX3-7349_Jan25)</td> <td>Jan-26</td> </tr> <tr> <td>DAE4ip</td> <td>SN: 1836</td> <td>04-Sep-25 (No. DAE4ip-1836_Sep25)</td> <td>Sep-26</td> </tr> </tbody> </table>				Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Cal	Power Sensor R&S NRP-33T	SN: 100967	30-Apr-25 (No. 1020-300791789)	Apr-26	Power Sensor R&S NRP18A	SN: 101859	06-Feb-25 (No. 4030A315009541)	Feb-26	Spectrum Analyzer R&S FSV40	SN: 101832	29-Jan-25 (No. 4030A315009658)	Jan-26	3.5mm mismatch combination	SN: 1152	24-Mar-25 (No. 217-04293)	Mar-26	OCP DAK-12	SN: 1016	16-Sept-25 (No. OCP-DAK12-1016_Sep25)	Sep-26	OCP DAK-3.5	SN: 1249	16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)	Sep-26	Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26	DAE4ip	SN: 1836	04-Sep-25 (No. DAE4ip-1836_Sep25)	Sep-26
Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Cal																																				
Power Sensor R&S NRP-33T	SN: 100967	30-Apr-25 (No. 1020-300791789)	Apr-26																																				
Power Sensor R&S NRP18A	SN: 101859	06-Feb-25 (No. 4030A315009541)	Feb-26																																				
Spectrum Analyzer R&S FSV40	SN: 101832	29-Jan-25 (No. 4030A315009658)	Jan-26																																				
3.5mm mismatch combination	SN: 1152	24-Mar-25 (No. 217-04293)	Mar-26																																				
OCP DAK-12	SN: 1016	16-Sept-25 (No. OCP-DAK12-1016_Sep25)	Sep-26																																				
OCP DAK-3.5	SN: 1249	16-Sept-25 (No. OCP-DAK3.5-1249_Sep25)	Sep-26																																				
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26																																				
DAE4ip	SN: 1836	04-Sep-25 (No. DAE4ip-1836_Sep25)	Sep-26																																				
<table border="1" style="width:100%; border-collapse: collapse;"> <thead> <tr> <th>Secondary Standards</th> <th>ID</th> <th>Check Date (in house)</th> <th>Scheduled Check</th> </tr> </thead> <tbody> <tr> <td>ACAD Setup 1</td> <td>SN: 1000</td> <td>27-May-25 (No. 675-ACAD_Source_Box-250527)</td> <td>May-26</td> </tr> <tr> <td>Signal Generator R&S SMB100A</td> <td>SN: 182081</td> <td>27-May-25 (No. 675-CAL16-S4588-250527)</td> <td>May-26</td> </tr> <tr> <td>Mismatch; SMA</td> <td>SN: 1102</td> <td>24-Apr-25 (No. 675-Mismatch_SMA-250424)</td> <td>Apr-26</td> </tr> <tr> <td>OCP DAK-12</td> <td>SN: 1029</td> <td>27-Feb-25 (No. OCP-DAK12-1029_Feb25)</td> <td>Feb-26</td> </tr> <tr> <td>OCP DAK-3.5</td> <td>SN: 1336</td> <td>09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)</td> <td>Dec-25</td> </tr> </tbody> </table>				Secondary Standards	ID	Check Date (in house)	Scheduled Check	ACAD Setup 1	SN: 1000	27-May-25 (No. 675-ACAD_Source_Box-250527)	May-26	Signal Generator R&S SMB100A	SN: 182081	27-May-25 (No. 675-CAL16-S4588-250527)	May-26	Mismatch; SMA	SN: 1102	24-Apr-25 (No. 675-Mismatch_SMA-250424)	Apr-26	OCP DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26	OCP DAK-3.5	SN: 1336	09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)	Dec-25												
Secondary Standards	ID	Check Date (in house)	Scheduled Check																																				
ACAD Setup 1	SN: 1000	27-May-25 (No. 675-ACAD_Source_Box-250527)	May-26																																				
Signal Generator R&S SMB100A	SN: 182081	27-May-25 (No. 675-CAL16-S4588-250527)	May-26																																				
Mismatch; SMA	SN: 1102	24-Apr-25 (No. 675-Mismatch_SMA-250424)	Apr-26																																				
OCP DAK-12	SN: 1029	27-Feb-25 (No. OCP-DAK12-1029_Feb25)	Feb-26																																				
OCP DAK-3.5	SN: 1336	09-Dec-24 (No. OCP-DAK3.5-1336_Dec24)	Dec-25																																				
<table border="1" style="width:100%; border-collapse: collapse;"> <tr> <td style="width:30%;"></td> <td style="width:20%;">Name</td> <td style="width:20%;">Function</td> <td style="width:30%;">Signature</td> </tr> <tr> <td>Calibrated by</td> <td>Claudio Leubler</td> <td>Laboratory Technician</td> <td></td> </tr> <tr> <td>Approved by</td> <td>Sven Kühn</td> <td>Technical Manager</td> <td></td> </tr> </table> Issued: September 18, 2025 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.					Name	Function	Signature	Calibrated by	Claudio Leubler	Laboratory Technician		Approved by	Sven Kühn	Technical Manager																									
	Name	Function	Signature																																				
Calibrated by	Claudio Leubler	Laboratory Technician																																					
Approved by	Sven Kühn	Technical Manager																																					
Certificate No: D5GHzV2-1093_Sep25		Page 1 of 9																																					

Shenzhen Anbotek Compliance Laboratory Limited

Any unauthorized modification, forgery, or falsification of this document constitutes a violation of law and is subject to legal penalties. If you have any questions, you may scan the QR code to download the report for verification or contact us via email.

Hotline: 400-003-0500 web: www.anbotek.com E-mail: service@anbotek.com

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Glossary

TSL tissue simulating liquid
ConvF sensitivity in TSL / NORM x,y,z
N/A not applicable or not measured

Calibration is Performed According to the Following Standards

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices - Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation

- DASY System Handbook

Methods Applied and Interpretation of Parameters

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

D5GHzV2 - SN: 1093

September 17, 2025

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY8 Module SAR	17.0.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with spacer
Zoom Scan Resolution	dx, dy = 4mm, dz = 1.4mm	Graded Ratio = 1.4 mm (Z direction)
Frequency	5250MHz $\pm$ 1MHz 5600MHz $\pm$ 1MHz 5750MHz $\pm$ 1MHz	

HSL parameters at 5250 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal HSL parameters	22.0 °C	35.9	4.71 mho/m
Measured HSL parameters	(22.0 $\pm$ 0.2)°C	37.3 $\pm$ 6%	4.62 mho/m $\pm$ 6%
HSL temperature change during test	< 0.5 °C		

SAR result with HSL at 5250 MHz

SAR averaged over 1 cm ³ (1 g) of HSL	Condition	
SAR for nominal HSL parameters	20 dBm input power	8.29 W/kg
SAR for nominal HSL parameters	normalized to 1W	82.9 W/kg $\pm$ 19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of HSL	Condition	
SAR for nominal HSL parameters	20 dBm input power	2.36 W/kg
SAR for nominal HSL parameters	normalized to 1W	23.6 W/kg $\pm$ 19.5% (k = 2)

D5GHzV2 - SN: 1093

September 17, 2025

HSL parameters at 5600 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal HSL parameters	22.0 °C	35.5	5.07 mho/m
Measured HSL parameters	(22.0 ±0.2)°C	36.6 ±6%	4.99 mho/m ±6%
HSL temperature change during test	< 0.5 °C		

SAR result with HSL at 5600 MHz

SAR averaged over 1 cm ³ (1 g) of HSL	Condition	
SAR for nominal HSL parameters	20 dBm input power	8.14 W/kg
SAR for nominal HSL parameters	normalized to 1W	81.4 W/kg ±19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of HSL	Condition	
SAR for nominal HSL parameters	20 dBm input power	2.33 W/kg
SAR for nominal HSL parameters	normalized to 1W	23.3 W/kg ±19.5% (k = 2)

HSL parameters at 5750 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal HSL parameters	22.0 °C	35.4	5.22 mho/m
Measured HSL parameters	(22.0 ±0.2)°C	36.4 ±6%	5.16 mho/m ±6%
HSL temperature change during test	< 0.5 °C		

SAR result with HSL at 5750 MHz

SAR averaged over 1 cm ³ (1 g) of HSL	Condition	
SAR for nominal HSL parameters	20 dBm input power	7.79 W/kg
SAR for nominal HSL parameters	normalized to 1W	77.9 W/kg ±19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of HSL	Condition	
SAR for nominal HSL parameters	20 dBm input power	2.21 W/kg
SAR for nominal HSL parameters	normalized to 1W	22.1 W/kg ±19.5% (k = 2)

D5GHzV2 - SN: 1093

September 17, 2025

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters with HSL at 5250 MHz

Impedance	48.6 Ω – 4.8 j Ω
Return Loss	-25.9 dB

Antenna Parameters with HSL at 5600 MHz

Impedance	55.9 Ω – 1.0 j Ω
Return Loss	-25.0 dB

Antenna Parameters with HSL at 5750 MHz

Impedance	54.2 Ω – 1.3 j Ω
Return Loss	-27.5 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.207 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured. The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
-----------------	-------

D5GHzV2 - SN: 1093

September 17, 2025

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1093	5250	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10	CW, 0---		5250, 0	5.68	4.62	37.3

Hardware Setup

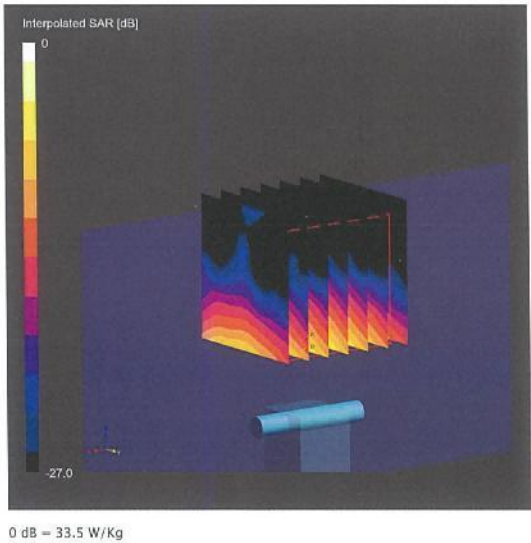
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2025-09-17	EX3DV4 - SN7349, 2025-01-10	DAE4lp Sn1836, 2025-09-04

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm ²]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2025-09-17
psSAR1g [W/Kg]	8.29
psSAR10g [W/Kg]	2.36
Power Drift [dB]	-0.06
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



D5GHzV2 - SN: 1093

September 17, 2025

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1093	5600	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10	CW, 0---		5600, 0	5.21	4.99	36.6

Hardware Setup

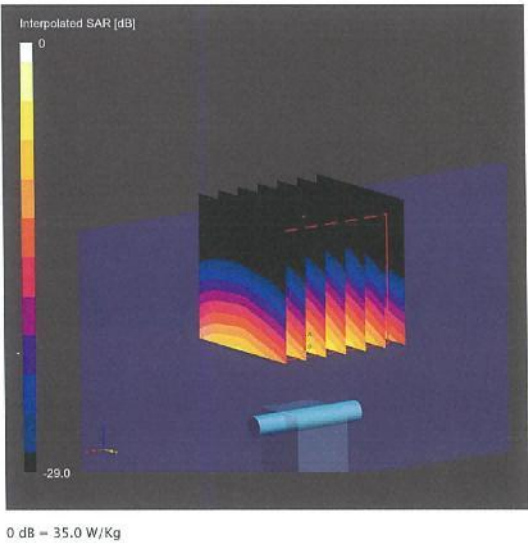
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V6.0 Center	HSL, 2025-09-17	EX3DV4 - SN7349, 2025-01-10	DAE4ip Sn1836, 2025-09-04

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAJA	N/A
Surface Detection	VMS - 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2025-09-17
psSAR1g [W/Kg]	8.14
psSAR10g [W/Kg]	2.33
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



D5GHzV2 - SN: 1093

September 17, 2025

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1093	5750	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10	CW, 0---		5750, 0	5.38	5.16	36.4

Hardware Setup

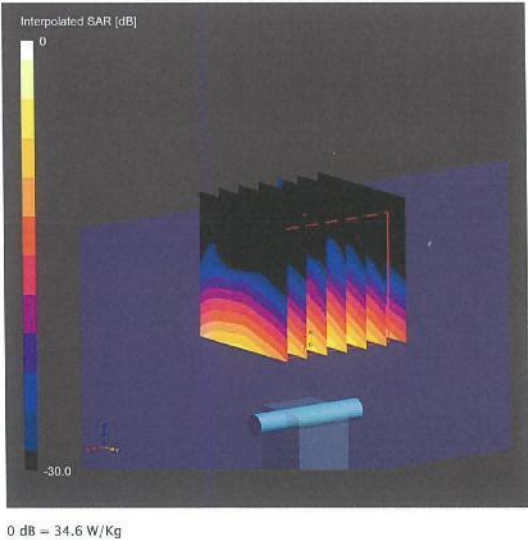
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2025-09-17	EX3DV4 - SN7349, 2025-01-10	DAE4/p Sn1836, 2025-09-04

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2025-09-17
psSAR1g [W/Kg]	7.79
psSAR10g [W/Kg]	2.21
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



D5GHzV2 - SN: 1093

September 17, 2025

Impedance Measurement Plot for HSL

